

Notice of References Cited	Application/Control No. 10/519,841	Applicant(s)/Patent Under Reexamination DIETSCHE ET AL.	
	Examiner Kevin R. Kruer	Art Unit 1773	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0104245	06-2003	Bergh et al.	428/690
*	B	US-5,334,842	08-1994	Van Havenbergh et al.	250/483.1
*	C	US-6,103,370	08-2000	Onozawa et al.	428/354
*	D	US-3,880,953	04-1975	Downey, Raymond E.	525/99
*	E	US-4,136,071	01-1979	Korpman, Ralf	524/534
*	F	US-6,500,883	12-2002	Mack et al.	523/213
*	G	US-6,482,489	11-2002	Otaki et al.	428/40.1
*	H	US-2003/0104199	06-2003	Kondo et al.	428/343
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	0405318671	12-1993	JP	Matsuoka	--
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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